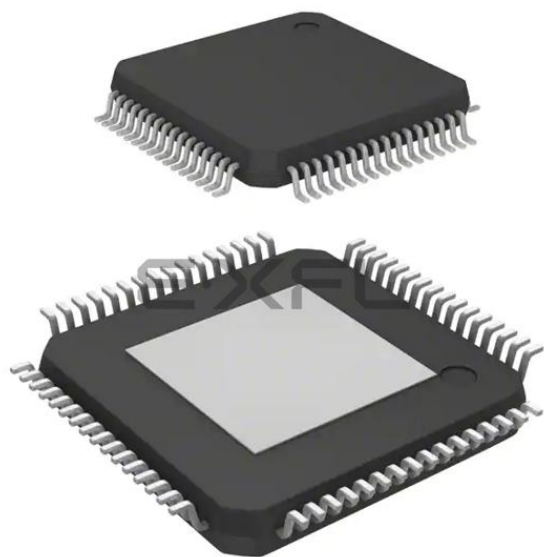




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Peripherals	DMA, I ² S, POR, PWM, WDT
Number of I/O	49
Program Memory Size	160KB (160K x 8)
Program Memory Type	FLASH
EEPROM Size	-
RAM Size	12K x 8
Voltage - Supply (Vcc/Vdd)	3V ~ 5.5V
Data Converters	A/D 10x12b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 125°C (TA)
Mounting Type	Surface Mount
Package / Case	64-LQFP Exposed Pad
Supplier Device Package	PG-LQFP-64-6
Purchase URL	https://www.e-xfl.com/product-detail/infineon-technologies/xc2331d20f66lraakxuma1

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Table 6 Pin Definitions and Functions (cont'd)

Pin	Symbol	Ctrl.	Type	Function
13	P5.2	I	In/B	Bit 2 of Port 5, General Purpose Input
	ADC0_CH2	I	In/B	Analog Input Channel 2 for ADC0
	TDI_A	I	In/B	JTAG Test Data Input
14	P5.3	I	In/B	Bit 3 of Port 5, General Purpose Input
	ADC0_CH3	I	In/B	Analog Input Channel 3 for ADC0
	T3INA	I	In/B	GPT12E Timer T3 Count/Gate Input
15	P5.5	I	In/B	Bit 5 of Port 5, General Purpose Input
	ADC0_CH5	I	In/B	Analog Input Channel 5 for ADC0
	CCU60_T12 HRB	I	In/B	External Run Control Input for T12 of CCU60
16	P5.6	I	In/B	Bit 6 of Port 5, General Purpose Input
	ADC0_CH6	I	In/B	Analog Input Channel 6 for ADC0
17	P5.4	I	In/B	Bit 4 of Port 5, General Purpose Input
	ADC0_CH4	I	In/B	Analog Input Channel 4 for ADC0
	CCU63_T12 HRB	I	In/B	External Run Control Input for T12 of CCU63
	T3EUDA	I	In/B	GPT12E Timer T3 External Up/Down Control Input
	TMS_A	I	In/B	JTAG Test Mode Selection Input
18	P5.7	I	In/B	Bit 7 of Port 5, General Purpose Input
	ADC0_CH7	I	In/B	Analog Input Channel 7 for ADC0
19	P5.8	I	In/B	Bit 8 of Port 5, General Purpose Input
	ADC0_CH8	I	In/B	Analog Input Channel 8 for ADC0
	CCU6x_T12H RC	I	In/B	External Run Control Input for T12 of CCU60/3
	CCU6x_T13H RC	I	In/B	External Run Control Input for T13 of CCU60/3
20	P5.9	I	In/B	Bit 9 of Port 5, General Purpose Input
	ADC0_CH9	I	In/B	Analog Input Channel 9 for ADC0
	CC2_T7IN	I	In/B	CAPCOM2 Timer T7 Count Input

General Device Information

Table 6 Pin Definitions and Functions (cont'd)

Pin	Symbol	Ctrl.	Type	Function
29	P2.2	O0 / I	St/B	Bit 2 of Port 2, General Purpose Input/Output
	TxDC1	O1	St/B	CAN Node 1 Transmit Data Output
	CCU63_CC6 2	O2	St/B	CCU63 Channel 2 Output
	CCU63_CC6 2INB	I	St/B	CCU63 Channel 2 Input
	ESR2_5	I	St/B	ESR2 Trigger Input 5
	ERU_1A0	I	St/B	External Request Unit Channel 1 Input A0
30	P2.3	O0 / I	St/B	Bit 3 of Port 2, General Purpose Input/Output
	U0C0_DOUT	O1	St/B	USIC0 Channel 0 Shift Data Output
	CCU63_COU T63	O2	St/B	CCU63 Channel 3 Output
	CC2_CC16	O3 / I	St/B	CAPCOM2 CC16IO Capture Inp./ Compare Out.
	ESR2_0	I	St/B	ESR2 Trigger Input 0
	U0C0_DX0E	I	St/B	USIC0 Channel 0 Shift Data Input
	U0C1_DX0D	I	St/B	USIC0 Channel 1 Shift Data Input
	RxDC0A	I	St/B	CAN Node 0 Receive Data Input
31	P2.4	O0 / I	St/B	Bit 4 of Port 2, General Purpose Input/Output
	U0C1_DOUT	O1	St/B	USIC0 Channel 1 Shift Data Output
	TxDC0	O2	St/B	CAN Node 0 Transmit Data Output
	CC2_CC17	O3 / I	St/B	CAPCOM2 CC17IO Capture Inp./ Compare Out.
	ESR1_0	I	St/B	ESR1 Trigger Input 0
	U0C0_DX0F	I	St/B	USIC0 Channel 0 Shift Data Input
	RxDC1A	I	St/B	CAN Node 1 Receive Data Input
32	P2.5	O0 / I	St/B	Bit 5 of Port 2, General Purpose Input/Output
	U0C0_SCLK OUT	O1	St/B	USIC0 Channel 0 Shift Clock Output
	TxDC0	O2	St/B	CAN Node 0 Transmit Data Output
	CC2_CC18	O3 / I	St/B	CAPCOM2 CC18IO Capture Inp./ Compare Out.
	U0C0_DX1D	I	St/B	USIC0 Channel 0 Shift Clock Input
	ESR1_10	I	St/B	ESR1 Trigger Input 10

General Device Information

Table 6 Pin Definitions and Functions (cont'd)

Pin	Symbol	Ctrl.	Type	Function
43	P10.0	O0 / I	St/B	Bit 0 of Port 10, General Purpose Input/Output
	U0C1_DOUT	O1	St/B	USIC0 Channel 1 Shift Data Output
	CCU60_CC60	O2	St/B	CCU60 Channel 0 Output
	CCU60_CC60INA	I	St/B	CCU60 Channel 0 Input
	ESR1_2	I	St/B	ESR1 Trigger Input 2
	U0C0_DX0A	I	St/B	USIC0 Channel 0 Shift Data Input
	U0C1_DX0A	I	St/B	USIC0 Channel 1 Shift Data Input
	U1C1_DX0C	I	St/B	USIC1 Channel 1 Shift Data Input
44	P10.1	O0 / I	St/B	Bit 1 of Port 10, General Purpose Input/Output
	U0C0_DOUT	O1	St/B	USIC0 Channel 0 Shift Data Output
	CCU60_CC61	O2	St/B	CCU60 Channel 1 Output
	CCU60_CC61INA	I	St/B	CCU60 Channel 1 Input
	U0C0_DX0B	I	St/B	USIC0 Channel 0 Shift Data Input
	U0C0_DX1A	I	St/B	USIC0 Channel 0 Shift Clock Input
45	P10.2	O0 / I	St/B	Bit 2 of Port 10, General Purpose Input/Output
	U0C0_SCLKOUT	O1	St/B	USIC0 Channel 0 Shift Clock Output
	CCU60_CC62	O2	St/B	CCU60 Channel 2 Output
	CCU60_CC62INA	I	St/B	CCU60 Channel 2 Input
	U0C0_DX1B	I	St/B	USIC0 Channel 0 Shift Clock Input
46	P10.3	O0 / I	St/B	Bit 3 of Port 10, General Purpose Input/Output
	CCU60_COUT60	O2	St/B	CCU60 Channel 0 Output
	U0C0_DX2A	I	St/B	USIC0 Channel 0 Shift Control Input
	U0C1_DX2A	I	St/B	USIC0 Channel 1 Shift Control Input
	RxDC1D	I	St/B	CAN Node 1 Receive Data Input

General Device Information

Table 6 Pin Definitions and Functions (cont'd)

Pin	Symbol	Ctrl.	Type	Function
58	P10.10	O0 / I	St/B	Bit 10 of Port 10, General Purpose Input/Output
	U0C0_SELO0	O1	St/B	USIC0 Channel 0 Select/Control 0 Output
	CCU60_COUT63	O2	St/B	CCU60 Channel 3 Output
	U1C0_DOUT	O3	St/B	USIC1 Channel 0 Shift Data Output
	U0C0_DX2C	I	St/B	USIC0 Channel 0 Shift Control Input
	TDI_B	I	St/B	JTAG Test Data Input
	U0C1_DX1A	I	St/B	USIC0 Channel 1 Shift Clock Input
59	P10.11	O0 / I	St/B	Bit 11 of Port 10, General Purpose Input/Output
	U1C0_SCLKOUT	O1	St/B	USIC1 Channel 0 Shift Clock Output
	BRKOUT	O2	St/B	OCDS Break Signal Output
	U1C0_DX1D	I	St/B	USIC1 Channel 0 Shift Clock Input
	TMS_B	I	St/B	JTAG Test Mode Selection Input
	RxDC1B	I	St/B	CAN Node 1 Receive Data Input
60	P10.12	O0 / I	St/B	Bit 12 of Port 10, General Purpose Input/Output
	U1C0_DOUT	O1	St/B	USIC1 Channel 0 Shift Data Output
	U0C0_DOUT	O2	St/B	USIC0 Channel 0 Shift Data Output
	CCU63_COUT62	O3	St/B	CCU63 Channel 2 Output
	TDO_A	OH	St/B	DAP1/JTAG Test Data Output
	SPD_0	I/OH	St/B	SPD Input/Output
	C0	I	St/B	Configuration Pin 0
	U0C0_DX0D	I	St/B	USIC0 Channel 0 Shift Data Input
	U1C0_DX0C	I	St/B	USIC1 Channel 0 Shift Data Input
	U1C0_DX1E	I	St/B	USIC1 Channel 0 Shift Clock Input
61	XTAL2	O	Sp/M	Crystal Oscillator Amplifier Output

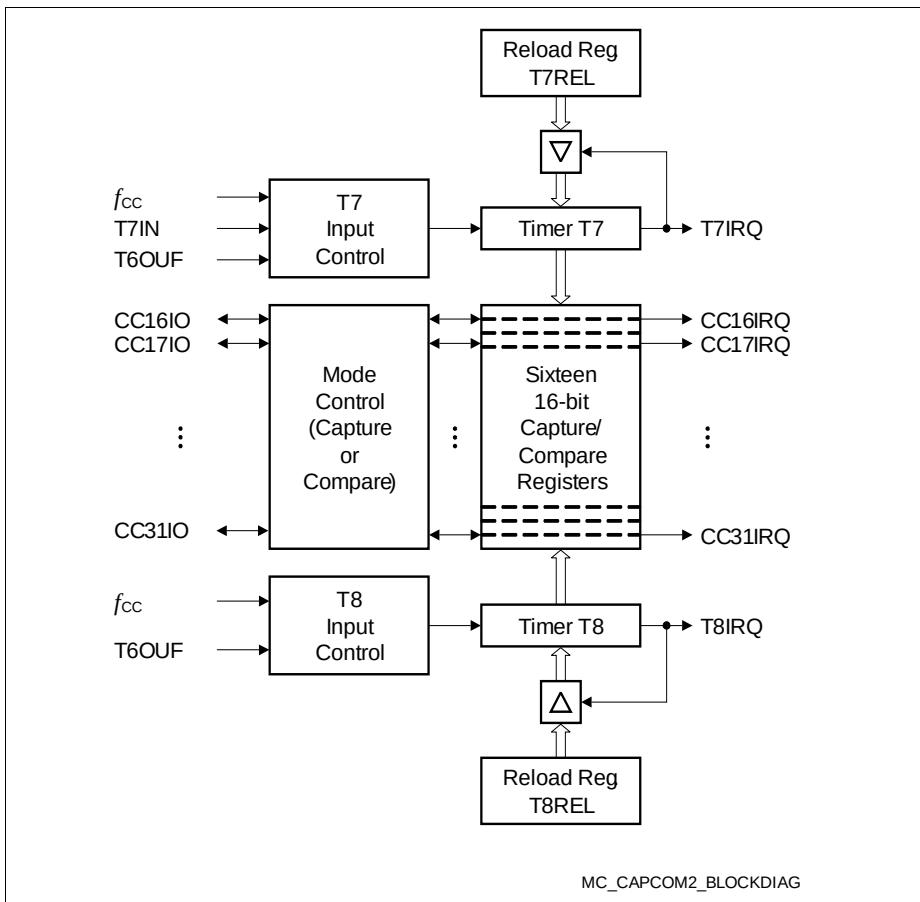


Figure 5 CAPCOM Unit Block Diagram

3.8 Capture/Compare Units CCU6x

The XC233[01]D types feature the CCU60 and CCU63 units.

CCU6 is a high-resolution capture and compare unit with application-specific modes. It provides inputs to start the timers synchronously, an important feature in devices with several CCU6 modules.

The module provides two independent timers (T12, T13), that can be used for PWM generation, especially for AC motor control. Additionally, special control modes for block commutation and multi-phase machines are supported.

Timer 12 Features

- Three capture/compare channels, where each channel can be used either as a capture or as a compare channel.
- Supports generation of a three-phase PWM (six outputs, individual signals for high-side and low-side switches)
- 16-bit resolution, maximum count frequency = peripheral clock
- Dead-time control for each channel to avoid short circuits in the power stage
- Concurrent update of the required T12/13 registers
- Center-aligned and edge-aligned PWM can be generated
- Single-shot mode supported
- Many interrupt request sources
- Hysteresis-like control mode
- Automatic start on a HW event (T12HR, for synchronization purposes)

Timer 13 Features

- One independent compare channel with one output
- 16-bit resolution, maximum count frequency = peripheral clock
- Can be synchronized to T12
- Interrupt generation at period match and compare match
- Single-shot mode supported
- Automatic start on a HW event (T13HR, for synchronization purposes)

Additional Features

- Block commutation for brushless DC drives implemented
- Position detection via Hall sensor pattern
- Automatic rotational speed measurement for block commutation
- Integrated error handling
- Fast emergency stop without CPU load via external signal ($\overline{\text{CTRAP}}$)
- Control modes for multi-channel AC drives
- Output levels can be selected and adapted to the power stage

Functional Description

Table 11 Instruction Set Summary (cont'd)

Mnemonic	Description	Bytes
ROL/ROR	Rotate left/right direct word GPR	2
ASHR	Arithmetic (sign bit) shift right direct word GPR	2
MOV(B)	Move word (byte) data	2 / 4
MOVBS/Z	Move byte operand to word op. with sign/zero extension	2 / 4
JMPA/I/R	Jump absolute/indirect/relative if condition is met	4
JMPS	Jump absolute to a code segment	4
JB(C)	Jump relative if direct bit is set (and clear bit)	4
JNB(S)	Jump relative if direct bit is not set (and set bit)	4
CALLA/I/R	Call absolute/indirect/relative subroutine if condition is met	4
CALLS	Call absolute subroutine in any code segment	4
PCALL	Push direct word register onto system stack and call absolute subroutine	4
TRAP	Call interrupt service routine via immediate trap number	2
PUSH/POP	Push/pop direct word register onto/from system stack	2
SCXT	Push direct word register onto system stack and update register with word operand	4
RET(P)	Return from intra-segment subroutine (and pop direct word register from system stack)	2
RETS	Return from inter-segment subroutine	2
RETI	Return from interrupt service subroutine	2
SBRK	Software Break	2
SRST	Software Reset	4
IDLE	Enter Idle Mode	4
PWRDN	Unused instruction ¹⁾	4
SRVWDT	Service Watchdog Timer	4
DISWDT/ENWDT	Disable/Enable Watchdog Timer	4
EINIT	End-of-Initialization Register Lock	4
ATOMIC	Begin ATOMIC sequence	2
EXTR	Begin EXTENDED Register sequence	2
EXTP(R)	Begin EXTENDED Page (and Register) sequence	2 / 4
EXTS(R)	Begin EXTENDED Segment (and Register) sequence	2 / 4

Functional Description

Table 11 Instruction Set Summary (cont'd)

Mnemonic	Description	Bytes
NOP	Null operation	2
CoMUL/CoMAC	Multiply (and accumulate)	4
CoADD/CoSUB	Add/Subtract	4
Co(A)SHR	(Arithmetic) Shift right	4
CoSHL	Shift left	4
CoLOAD/STORE	Load accumulator/Store MAC register	4
CoCMP	Compare	4
CoMAX/MIN	Maximum/Minimum	4
CoABS/CoRND	Absolute value/Round accumulator	4
CoMOV	Data move	4
CoNEG/NOP	Negate accumulator/Null operation	4

- 1) The Enter Power Down Mode instruction is not used in the XC233[01]D, due to the enhanced power control scheme. PWRDN will be correctly decoded, but will trigger no action.

8) Value is controlled by on-chip regulator.

4.2 Voltage Range definitions

The XC233[01]D timing depends on the supply voltage. If such a dependency exists the timing values are given for 2 voltage areas commonly used. The voltage areas are defined in the following tables.

Table 14 Upper Voltage Range Definition

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Digital supply voltage for IO pads and voltage regulators	V_{DDP} SR	4.5	5.0	5.5	V	

Table 15 Lower Voltage Range Definition

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Digital supply voltage for IO pads and voltage regulators	V_{DDP} SR	3.0	3.3	4.5	V	

4.2.1 Parameter Interpretation

The parameters listed in the following include both the characteristics of the XC233[01]D and its demands on the system. To aid in correctly interpreting the parameters when evaluating them for a design, they are marked accordingly in the column "Symbol":

CC (Controller Characteristics):

The logic of the XC233[01]D provides signals with the specified characteristics.

SR (System Requirement):

The external system must provide signals with the specified characteristics to the XC233[01]D.

Electrical Parameters

- 4) This value includes a hysteresis of approximately 50 mV for rising voltage.
- 5) V_{LV} = selected SWD voltage level
- 6) The limit $V_{LV} - 0.10$ V is valid for the OK1 level. The limit for the OK2 level is $V_{LV} - 0.15$ V.

Conditions for t_{SPO} Timing Measurement

The time required for the transition from **Power-On** to **Base** mode is called t_{SPO} . It is measured under the following conditions:

Precondition: The pad supply is valid, i.e. V_{DDPB} is above 3.0 V and remains above 3.0 V even though the XC233[01]D is starting up. No debugger is attached.

Start condition: Power on reset is removed ($\overline{PORST} = 1$).

End condition: External pin toggle caused by first user instruction executed from Flash after startup.

Conditions for t_{SSO} Timing Measurement

The time required for the transition from **Stopover** to **Stopover Waked-Up** mode is called t_{SSO} . It is measured under the following conditions:

Precondition: The **Stopover** mode has been entered using the procedure defined in the Programmer's Guide.

Start condition: Pin toggle on $\overline{ESR}$ pin triggering the startup sequence.

End condition: External pin toggle caused by first user instruction executed from PSRAM after startup.

4.7 AC Parameters

These parameters describe the dynamic behavior of the XC233[01]D.

4.7.1 Testing Waveforms

These values are used for characterization and production testing (except pin XTAL1).

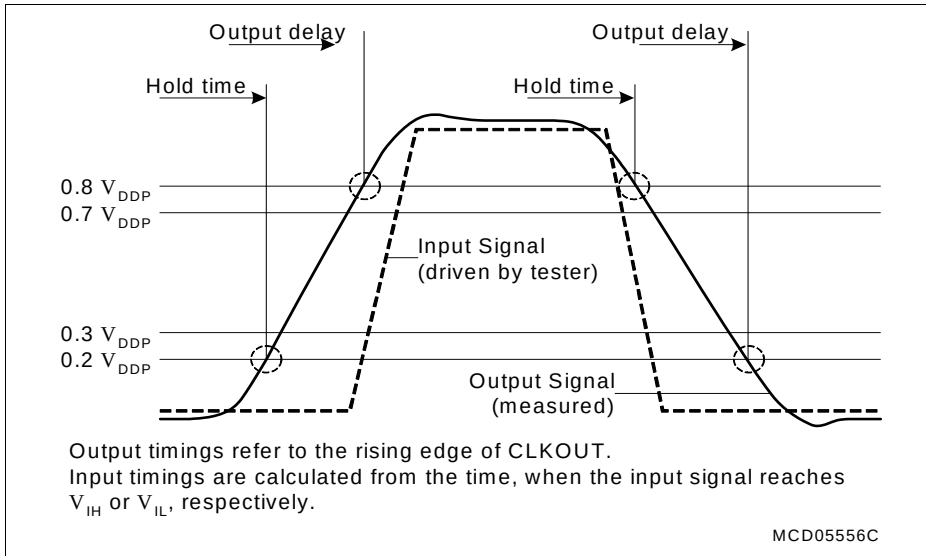


Figure 16 Input Output Waveforms

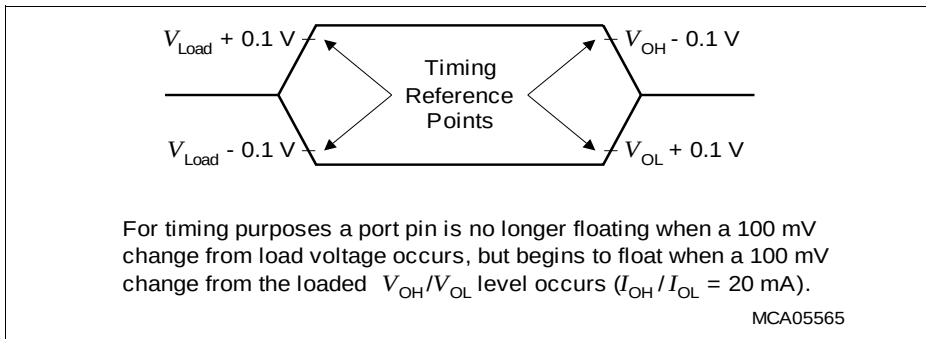


Figure 17 Floating Waveforms

Direct Drive

When direct drive operation is selected (SYSCON0.CLKSEL = 11_B), the system clock is derived directly from the input clock signal CLKIN1:

$$f_{SYS} = f_{IN}$$

The frequency of f_{SYS} is the same as the frequency of f_{IN} . In this case the high and low times of f_{SYS} are determined by the duty cycle of the input clock f_{IN} .

Selecting Bypass Operation from the XTAL1¹⁾ input and using a divider factor of 1 results in a similar configuration.

Prescaler Operation

When prescaler operation is selected (SYSCON0.CLKSEL = 10_B, PLLCON0.VCOBY = 1_B), the system clock is derived either from the crystal oscillator (input clock signal XTAL1) or from the internal clock source through the output prescaler K1 (= K1DIV+1):

$$f_{SYS} = f_{OSC} / K1$$

If a divider factor of 1 is selected, the frequency of f_{SYS} equals the frequency of f_{OSC} . In this case the high and low times of f_{SYS} are determined by the duty cycle of the input clock f_{OSC} (external or internal).

The lowest system clock frequency results from selecting the maximum value for the divider factor K1:

$$f_{SYS} = f_{OSC} / 1024$$

4.7.2.1 Phase Locked Loop (PLL)

When PLL operation is selected (SYSCON0.CLKSEL = 10_B, PLLCON0.VCOBY = 0_B), the on-chip phase locked loop is enabled and provides the system clock. The PLL multiplies the input frequency by the factor **F** ($f_{SYS} = f_{IN} \times F$).

F is calculated from the input divider P (= PDIV+1), the multiplication factor N (= NDIV+1), and the output divider K2 (= K2DIV+1):

$$(F = N / (P \times K2))$$

The input clock can be derived either from an external source at XTAL1 or from the on-chip clock source.

The PLL circuit synchronizes the system clock to the input clock. This synchronization is performed smoothly so that the system clock frequency does not change abruptly.

Adjustment to the input clock continuously changes the frequency of f_{SYS} so that it is locked to f_{IN} . The slight variation causes a jitter of f_{SYS} which in turn affects the duration of individual TCSSs.

1) Voltages on XTAL1 must comply to the core supply voltage V_{DDIM} .

4.7.3 External Clock Input Parameters

These parameters specify the external clock generation for the XC233[01]D. The clock can be generated in two ways:

- By connecting a **crystal or ceramic resonator** to pins XTAL1/XTAL2.
- By supplying an **external clock signal**. This clock signal can be supplied either to pin XTAL1 (core voltage domain) or to pin CLKIN1 (IO voltage domain).

If connected to CLKIN1, the input signal must reach the defined input levels V_{IL} and V_{IH} . If connected to XTAL1, a minimum amplitude V_{AX1} (peak-to-peak voltage) is sufficient for the operation of the on-chip oscillator.

Note: The given clock timing parameters ($t_1 \dots t_4$) are only valid for an external clock input signal.

Note: Operating Conditions apply.

Table 29 External Clock Input Characteristics

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Oscillator frequency	f_{OSC} SR	4	—	40	MHz	Input= Clock Signal
		4	—	16	MHz	Input= Crystal or Resonator
XTAL1 input current absolute value	$ I_{IL} $ CC	—	—	20	μA	
Input clock high time	t_1 SR	6	—	—	ns	
Input clock low time	t_2 SR	6	—	—	ns	
Input clock rise time	t_3 SR	—	8	8	ns	
Input clock fall time	t_4 SR	—	8	8	ns	
Input voltage amplitude on XTAL1 ¹⁾	V_{AX1} SR	0.3 x V_{DDIM}	—	—	V	$f_{OSC} \geq 4$ MHz; $f_{OSC} \leq 16$ MHz
		0.4 x V_{DDIM}	—	—	V	$f_{OSC} \geq 16$ MHz; $f_{OSC} \leq 25$ MHz
		0.5 x V_{DDIM}	—	—	V	$f_{OSC} \geq 25$ MHz; $f_{OSC} \leq 40$ MHz
Input voltage range limits for signal on XTAL1	V_{IX1} SR	-1.7 + V_{DDIM}	—	1.7	V	²⁾

1) The amplitude voltage V_{AX1} refers to the offset voltage V_{OFF} . This offset voltage must be stable during the operation and the resulting voltage peaks must remain within the limits defined by V_{IX1} .

Electrical Parameters

Table 33 is valid under the following conditions: $C_L = 20$ pF; SSC= master ; voltage_range= lower

Table 33 USIC SSC Master Mode Timing for Lower Voltage Range

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Slave select output SELO active to first SCLKOUT transmit edge	t_1 CC	$t_{SYS} - 10^{1)}$	—	—	ns	
Slave select output SELO inactive after last SCLKOUT receive edge	t_2 CC	$t_{SYS} - 9^{1)}$	—	—	ns	
Data output DOUT valid time	t_3 CC	-7	—	11	ns	
Receive data input setup time to SCLKOUT receive edge	t_4 SR	40	—	—	ns	
Data input DX0 hold time from SCLKOUT receive edge	t_5 SR	-5	—	—	ns	

1) $t_{SYS} = 1 / f_{SYS}$

Table 34 is valid under the following conditions: $C_L = 20$ pF; SSC= slave ; voltage_range= upper

Table 34 USIC SSC Slave Mode Timing for Upper Voltage Range

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Select input DX2 setup to first clock input DX1 transmit edge ¹⁾	t_{10} SR	10	—	—	ns	
Select input DX2 hold after last clock input DX1 receive edge ¹⁾	t_{11} SR	7	—	—	ns	
Receive data input setup time to shift clock receive edge ¹⁾	t_{12} SR	7	—	—	ns	

Electrical Parameters

Table 34 USIC SSC Slave Mode Timing for Upper Voltage Range (cont'd)

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Data input DX0 hold time from clock input DX1 receive edge ¹⁾	t_{13} SR	5	—	—	ns	
Data output DOUT valid time	t_{14} CC	7	—	33	ns	

1) These input timings are valid for asynchronous input signal handling of slave select input, shift clock input, and receive data input (bits DXnCR.DSEN = 0).

Table 35 is valid under the following conditions: $C_L = 20$ pF; SSC= slave ; voltage_range= lower

Table 35 USIC SSC Slave Mode Timing for Lower Voltage Range

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Select input DX2 setup to first clock input DX1 transmit edge ¹⁾	t_{10} SR	10	—	—	ns	
Select input DX2 hold after last clock input DX1 receive edge ¹⁾	t_{11} SR	7	—	—	ns	
Receive data input setup time to shift clock receive edge ¹⁾	t_{12} SR	7	—	—	ns	
Data input DX0 hold time from clock input DX1 receive edge ¹⁾	t_{13} SR	5	—	—	ns	
Data output DOUT valid time	t_{14} CC	8	—	41	ns	

1) These input timings are valid for asynchronous input signal handling of slave select input, shift clock input, and receive data input (bits DXnCR.DSEN = 0).

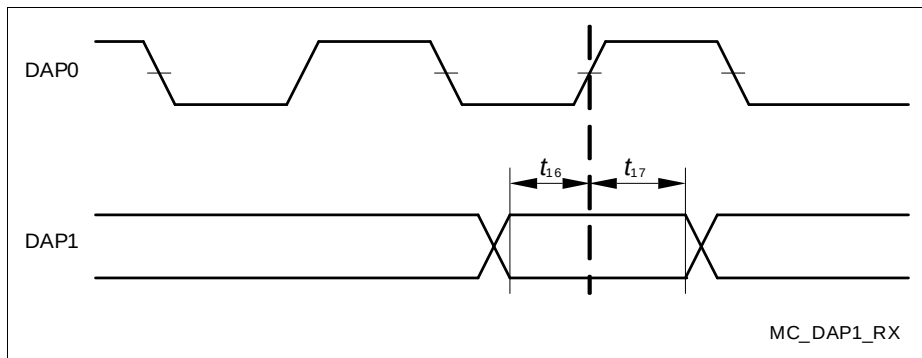


Figure 23 DAP Timing Host to Device

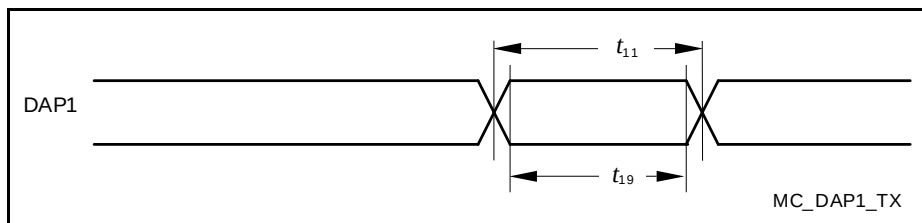


Figure 24 DAP Timing Device to Host

Note: The transmission timing is determined by the receiving debugger by evaluating the sync-request synchronization pattern telegram.

particular, the size of the Exposed Pad (if present) may vary.

If different device types are considered or planned for an application, it must be ensured that the board layout fits all packages under consideration.

Package Outlines

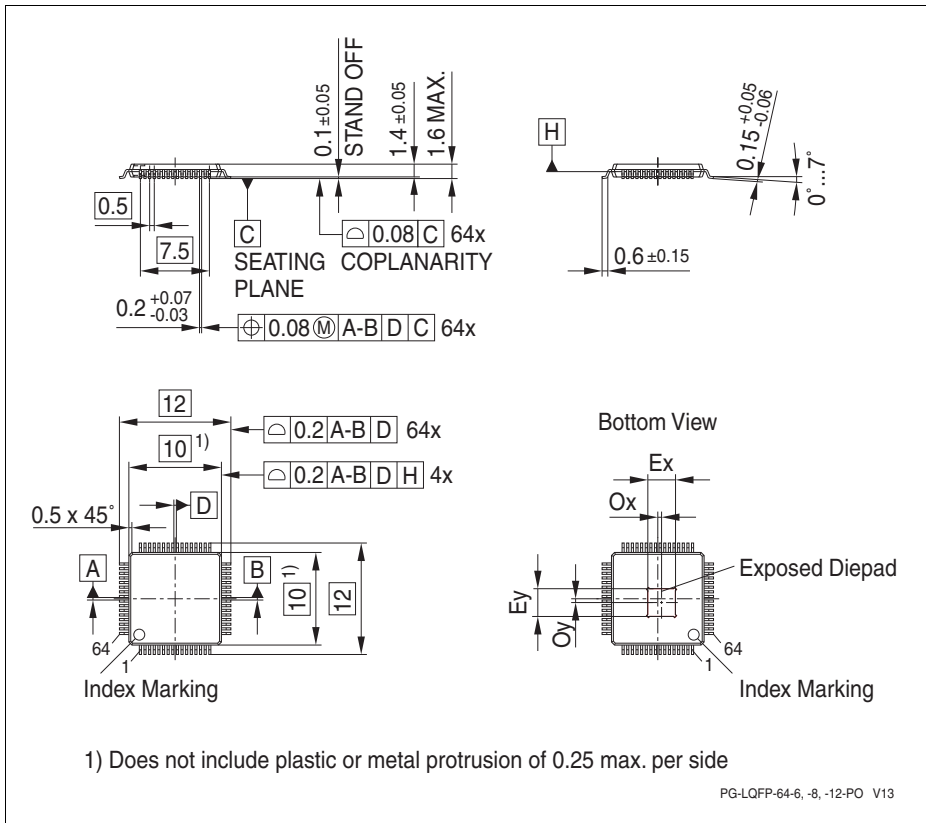


Figure 27 PG-LQFP-64-22/-24 (Plastic Green Thin Quad Flat Package)

All dimensions in mm.

You can find complete information about Infineon packages, packing and marking in our Infineon Internet Page "Packages": <http://www.infineon.com/packages>

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